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February 2002

IRFP460C

FAIRCHILD

SEMICONDUCTOR®

IRFP460C 500V N-Channel MOSFET

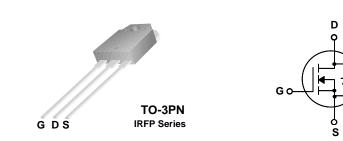
General Description

These N-Channel enhancement mode power field effect transistors are produced using Fairchild's proprietary, planar stripe, DMOS technology.

This advanced technology has been especially tailored to minimize on-state resistance, provide superior switching performance, and withstand high energy pulse in the avalanche and commutation mode. These devices are well suited for high efficiency switch mode power supplies and power factor corrections.

Features

- 20A, 500V, $R_{DS(on)} = 0.24\Omega @V_{GS} = 10 V$ Low gate charge (typical 130nC)
- Low Crss (typical 60 pF)
- · Fast switching
- 100% avalanche tested
- Improved dv/dt capability



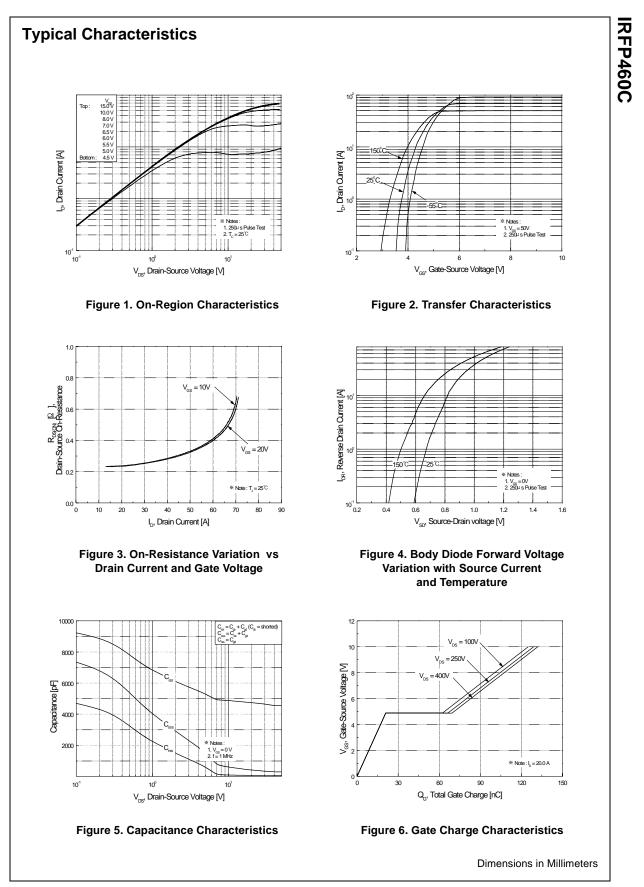
Absolute Maximum Ratings T_C = 25°C unless otherwise noted

Symbol	Parameter		IRFP460C	Units
V _{DSS}	Drain-Source Voltage		500	V
I _D	Drain Current - Continuous ($T_C = 25^{\circ}C$) - Continuous ($T_C = 100^{\circ}C$)		20	Α
			12.5	A
I _{DM}	Drain Current - Pulsed	(Note 1)	80	A
V _{GSS}	Gate-Source Voltage		± 30	V
E _{AS}	Single Pulsed Avalanche Energy	(Note 2)	1050	mJ
I _{AR}	Avalanche Current	(Note 1)	20	А
E _{AR}	Repetitive Avalanche Energy	(Note 1)	23.5	mJ
dv/dt	Peak Diode Recovery dv/dt	(Note 3)	4.5	V/ns
PD	Power Dissipation (T _C = 25°C)		235	W
	- Derate above 25°C		1.88	W/°C
T _J , T _{STG}	Operating and Storage Temperature Range		-55 to +150	°C
ΤL	Maximum lead temperature for soldering purposes, 1/8" from case for 5 seconds		300	°C

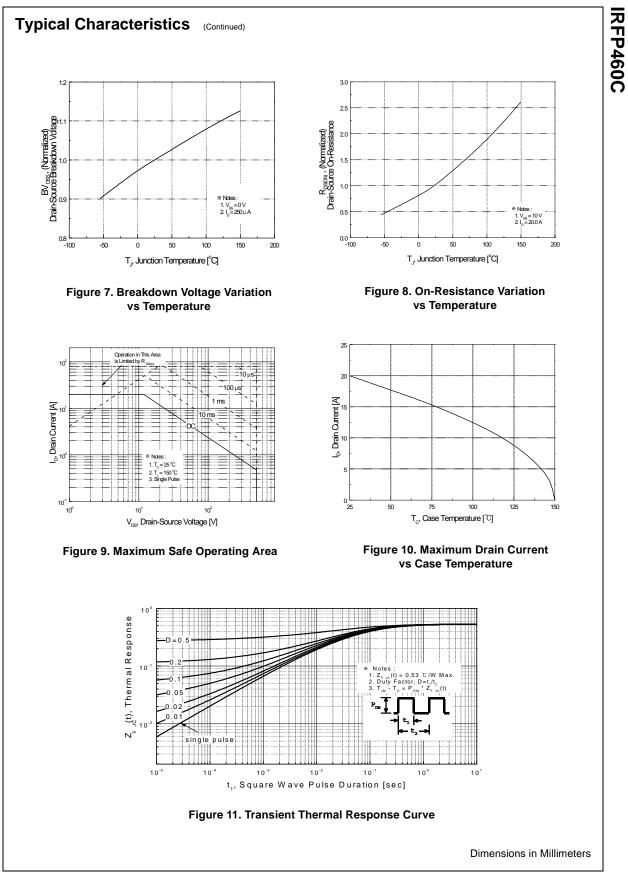
Thermal Characteristics

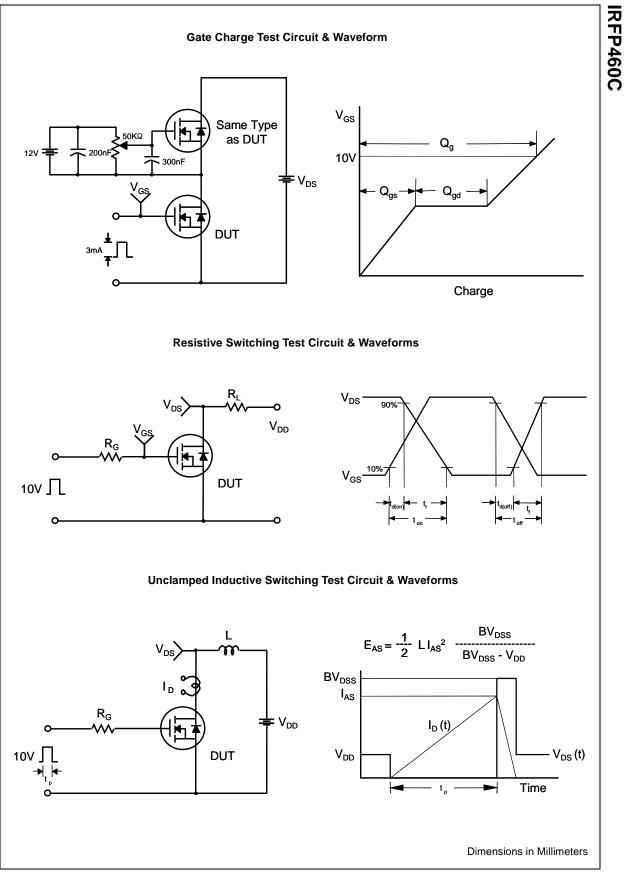
Symbol	Parameter	Тур	Max	Units
$R_{ extsf{ heta}JC}$	Thermal Resistance, Junction-to-Case		0.53	°C/W
$R_{\theta CS}$	Thermal Resistance, Case-to-Sink	0.24		°C/W
$R_{ extsf{ heta}JA}$	Thermal Resistance, Junction-to-Ambient		40	°C/W

	Parameter Test Conditions		S	Min	Тур	Max	Units
	naracteristics						
BV _{DSS}	Drain-Source Breakdown Voltage	V _{GS} = 0 V, I _D = 250 μA		500			V
ABV _{DSS}	Breakdown Voltage Temperature			000			
ΔT _J	Coefficient	$I_D = 250 \ \mu A$, Referenced	d to 25°C		0.55		V/°C
I _{DSS}	Zana Oata Malta na Duain Ourreat	$V_{DS} = 500 \text{ V}, V_{GS} = 0 \text{ V}$				10	μA
	Zero Gate Voltage Drain Current	$V_{DS} = 400 \text{ V}, \text{ T}_{C} = 125^{\circ}\text{C}$			100	μΑ	
GSSF	Gate-Body Leakage Current, Forward	$V_{GS} = 30 \text{ V}, \text{ V}_{DS} = 0 \text{ V}$				100	nA
GSSR	Gate-Body Leakage Current, Reverse	V_{GS} = -30 V, V_{DS} = 0 V				-100	nA
on Ch	aracteristics						
	Gate Threshold Voltage	V _{DS} = V _{GS} , I _D = 250 μA		2.0		4.0	V
R _{DS(on)}	Static Drain-Source			2.0			
00(01)	On-Resistance	V _{GS} = 10 V, I _D = 10.0 A			0.2	0.24	Ω
FS	Forward Transconductance	V _{DS} = 50 V, I _D = 10.0 A	(Note 4)		18		S
_							
-	nic Characteristics				4500	6000	
Ciss	Input Capacitance	V _{DS} = 25 V, V _{GS} = 0 V,			4590 380	6000 460	pF
iss oss rss		V _{DS} = 25 V, V _{GS} = 0 V, f = 1.0 MHz			4590 380 60	6000 460 80	pF pF pF
C _{iss} C _{oss} C _{rss}	Input Capacitance Output Capacitance Reverse Transfer Capacitance				380	460	pF
C _{iss} C _{oss} C _{rss} Switc d(on)	Input Capacitance Output Capacitance Reverse Transfer Capacitance hing Characteristics Turn-On Delay Time Turn-On Rise Time	f = 1.0 MHz V _{DD} = 250 V, I _D = 20 A,			380 60 50 150	460 80 120 310	pF pF
Ciss Coss Crss Switc d(on) r d(off)	Input Capacitance Output Capacitance Reverse Transfer Capacitance hing Characteristics Turn-On Delay Time Turn-On Rise Time Turn-Off Delay Time	f = 1.0 MHz			380 60 50 150 380	460 80 120 310 770	pF pF ns ns
Ciss Coss Crss Switcl d(on) r d(off) f	Input Capacitance Output Capacitance Reverse Transfer Capacitance hing Characteristics Turn-On Delay Time Turn-On Rise Time Turn-Off Delay Time Turn-Off Fall Time	f = 1.0 MHz V _{DD} = 250 V, I _D = 20 A,	(Note 4, 5)		380 60 50 150 380 180	460 80 120 310 770 370	pF pF ns ns ns ns
Ciss Coss Crss Switc d(on) r d(off) f Qg	Input Capacitance Output Capacitance Reverse Transfer Capacitance hing Characteristics Turn-On Delay Time Turn-On Rise Time Turn-Off Delay Time Turn-Off Fall Time Total Gate Charge	f = 1.0 MHz V _{DD} = 250 V, I _D = 20 A,	(Note 4, 5)	 	380 60 50 150 380 180 130	460 80 120 310 770 370 170	pF pF ns ns ns ns nc
Ciss Coss Crss Switc d(on) r d(off) f Q _g Q _g	Input Capacitance Output Capacitance Reverse Transfer Capacitance hing Characteristics Turn-On Delay Time Turn-On Rise Time Turn-Off Delay Time Turn-Off Fall Time Total Gate Charge Gate-Source Charge	f = 1.0 MHz V _{DD} = 250 V, I _D = 20 A, R _G = 25 Ω		 	380 60 50 150 380 180 130 20	460 80 120 310 770 370 170 	pF pF ns ns ns nc nC
C_{iss} C_{oss} C_{rss} Switcl d(on) r d(off) f Q_{g} Q_{gs} Q_{gd}	Input Capacitance Output Capacitance Reverse Transfer Capacitance hing Characteristics Turn-On Delay Time Turn-On Rise Time Turn-Off Delay Time Turn-Off Fall Time Total Gate Charge Gate-Source Charge Gate-Drain Charge	f = 1.0 MHz $V_{DD} = 250 \text{ V}, \text{ I}_D = 20 \text{ A},$ $R_G = 25 \Omega$ $V_{DS} = 400 \text{ V}, \text{ I}_D = 20 \text{ A},$ $V_{GS} = 10 \text{ V}$	(Note 4, 5)	 	380 60 50 150 380 180 130	460 80 120 310 770 370 170	pF pF ns ns ns ns nc
$\frac{\text{Ciss}}{\text{Coss}}$ $\frac{\text{Coss}}{\text{Crss}}$ $\frac{\text{Switc}}{\text{d}(on)}$ $\frac{\text{d}(off)}{\text{f}}$ $\frac{\text{d}(off)}{\text{g}}$ $\frac{\text{g}}{\text{g}}$ $\frac{\text{Q}_{gs}}{\text{Q}_{gd}}$ $\frac{\text{Drain-S}}{\text{Coss}}$	Input Capacitance Output Capacitance Reverse Transfer Capacitance hing Characteristics Turn-On Delay Time Turn-On Rise Time Turn-Off Delay Time Turn-Off Fall Time Total Gate Charge Gate-Source Charge Gate-Drain Charge	f = 1.0 MHz $V_{DD} = 250 \text{ V}, \text{ I}_D = 20 \text{ A},$ $R_G = 25 \Omega$ $V_{DS} = 400 \text{ V}, \text{ I}_D = 20 \text{ A},$ $V_{GS} = 10 \text{ V}$ and Maximum Rating	(Note 4, 5)	 	380 60 50 150 380 180 130 20 45	460 80 120 310 770 370 170 	pF pF ns ns ns nc nC nC
Ciss Coss Crss Switc d(on) f d(off) f d Qg Qg Qgs Qgd Drain-S S	Input Capacitance Output Capacitance Reverse Transfer Capacitance hing Characteristics Turn-On Delay Time Turn-On Rise Time Turn-Off Delay Time Turn-Off Fall Time Total Gate Charge Gate-Source Charge Gate-Drain Charge Source Diode Characteristics ar Maximum Continuous Drain-Source Diode	f = 1.0 MHz V_{DD} = 250 V, I_D = 20 A, R_G = 25 Ω V_{DS} = 400 V, I_D = 20 A, V_{GS} = 10 V Add Maximum Rating ode Forward Current	(Note 4, 5)	 	380 60 50 150 380 180 130 20	460 80 120 310 770 370 170 20	pF pF ns ns ns nC nC nC
Ciss Coss Crss Switc d(on) f d(off) f Qg Qgs Qgd Drain-S s SM	Input Capacitance Output Capacitance Reverse Transfer Capacitance hing Characteristics Turn-On Delay Time Turn-On Rise Time Turn-Off Delay Time Turn-Off Fall Time Total Gate Charge Gate-Source Charge Gate-Drain Charge	f = 1.0 MHz V_{DD} = 250 V, I_D = 20 A, R_G = 25 Ω V_{DS} = 400 V, I_D = 20 A, V_{GS} = 10 V Add Maximum Rating ode Forward Current Forward Current	(Note 4, 5)	 	380 60 50 150 380 130 20 45	460 80 120 310 770 370 170 	pF pF ns ns ns nc nC nC
Ciss Coss Crss Switc d(on) r d(off) f Qg Qgs Qgd Drain-S s	Input Capacitance Output Capacitance Reverse Transfer Capacitance hing Characteristics Turn-On Delay Time Turn-On Rise Time Turn-Off Delay Time Turn-Off Fall Time Total Gate Charge Gate-Source Charge Gate-Drain Charge Source Diode Characteristics ar Maximum Continuous Drain-Source Diode F	f = 1.0 MHz V_{DD} = 250 V, I_D = 20 A, R_G = 25 Ω V_{DS} = 400 V, I_D = 20 A, V_{GS} = 10 V Add Maximum Rating ode Forward Current	(Note 4, 5)	 	380 60 50 150 380 130 20 45 	460 80 120 310 770 370 170 20 80	pF pF ns ns ns nC nC nC A A

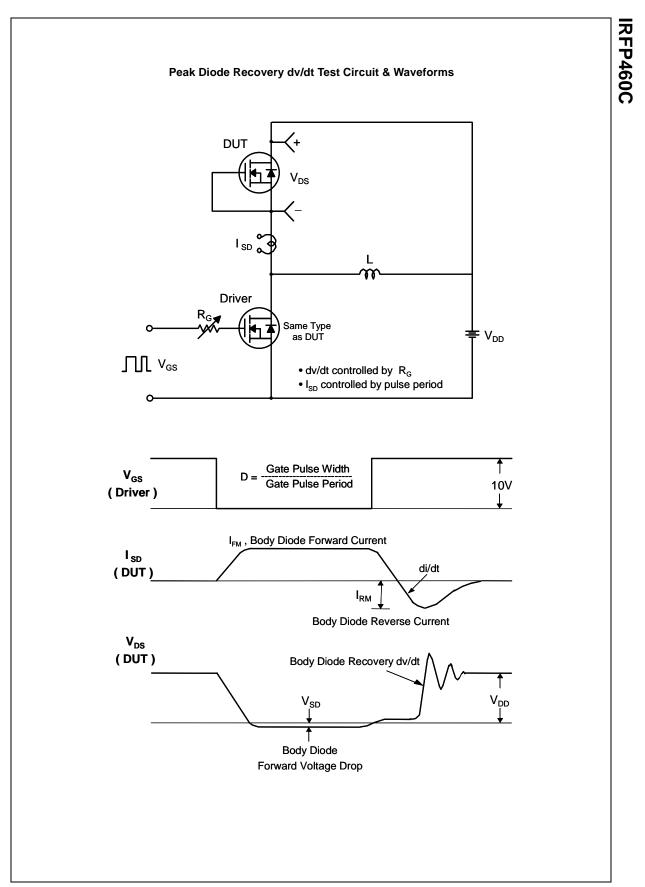


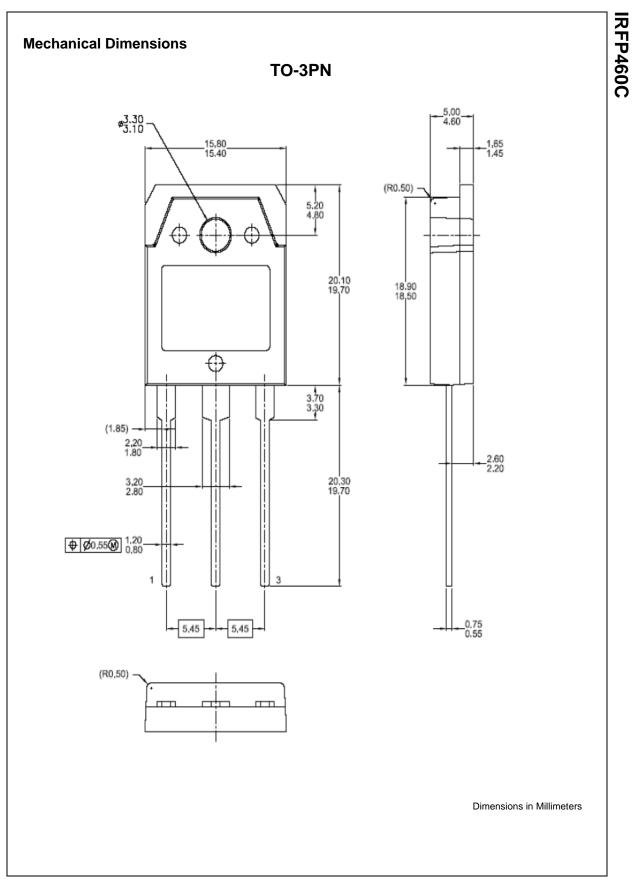
Rev. A, February 2002





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